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RDF Analysis of Tb-Fe Alloy Thin Films by Energy-Filtered Electron
Diffraction

Se Ahn Song* and D.J.H. Cockayne*

*Samsung Advanced Institute of Technology, Suwon 440-600, Korea

*Electron Microscope Unit, The University of Sydney, N.S.W. 2006, Australia

INTRODUCTION

Thin films of amorphous rare-earth - transition metal (RE-TM) alloy can be prepared with uniaxial magnetic anisotropy, which can be exploited for bubble domain memory devices [1]. These materials are now commercially used as magneto-optic recording media which can store/rewrite 650 Mb in a single 5.25" disk. The magneto-optic technology was reviewed elsewhere [2] and this MO device is becoming popular for databases, document filing, image processing works, etc.. In this study we investigated the short-range ordering of Tb-Fe alloy thin films by on-line diffraction analysis.

MATERIALS AND METHODS

Tb-Fe alloy films (Tb: 0, 5, 15, 22, 27, 100 at.%) were prepared by DC magnetron co-sputtering with thickness of 150 - 300 Å. Both sides of the Tb-Fe films were overcoated with amorphous Si₃N₄ thin films (100 Å thick each) by reactive gas sputtering in the sputter before exposure to air atmosphere to avoid oxidation. These film thicknesses can satisfy the single electron scattering approximation [3] for processing of experimentally collected data. Energy-filtered electron diffraction patterns from these Tb-Fe films were

collected at 300 kV (Philips EM430) with PEELS and the data were processed to reduced intensity function Φ (s) and finally to reduced density function $G(r)$ using established algorithms [4,5].

RESULTS AND DISCUSSIONS

Some investigations on the short-range ordering of RE-TM alloy films were already carried out by X-ray method ($Tb_{21}Fe_{79}$ [6], $Gd_{20}Co_{80}$ [7]) and by off-line electron diffraction analysis [8]. Our work is similar in composition of alloys to that of Tewes et al. [8] but is more elaborate with better resolution. The diffraction intensity of a- Si_3N_4 films were much weaker than those of Tb-Fe films, so it was almost negligible. The $G(r)$'s showed that Tb_5Fe_{95} film is partly disordered and HRTEM observation revealed that Fe nanocrystals were surrounded with amorphous Tb-Fe alloy phase. The $G(r)$ of $Tb_{22}Fe_{78}$ which is a compensation composition showed well-resolved 1st Fe-Fe (2.54 Å), 2nd Fe-Fe (2.88 Å) and Fe-Tb (3.10 Å) pair distances in the amorphous state. The whole $G(r)$'s represented that there is no Tb-Tb pair ordering in the Tb-Fe alloys. The $G(r)$ of overcoated a- Si_3N_4 film showed that the average bond distances are 1.69 Å for Si-N and 2.95 Å for N-N.

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